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Time Sent: November 10, 2005 Date: Telephone No: Facsimile No: Company: To: 571-273-8300 Commissioner of Patents USPTO (949) 757-7165 Direct Phone: Andrew D. Mickelsen From: amickelsen@mwe.com E-Mail: (949) 757-6052 Direct Phone: Cathy FitzGerald Sent By: No Original to Follow by Mail: 070602-0406-8565 Client/Matter/Tkpr: 2 Number of Pages, Including Cover:

Re:

U.S. Patent Application No. 10/692,704

METHOD AND SYSTEM FOR MEASURING DIFFERENTIAL SCATTERING OF

LIGHT OFF OF SAMPLE SURFACES

Inventor: Brian B. Jones Attorney Docket: 070602-0406

Message:

ORC 376410-1.070602.0406

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PAGE 1/2 * RCVD AT 11/10/2005 6:22:37 PM [Eastern Standard Time] * SVR:USPTO-EFXRF-6/24 * DNIS:2738300 * CSID:949 851 9348 * DURATION (mm-ss):00-40

Docket No.: 070602-0406

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PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

Customer Number: 31824

Brian B. Jones

Confirmation Number: 9806

Application No.: 10/692,704

Group Art Unit: 2877

Filed: October 24, 2003

Examiner: Amanda H. Merlino

For:

METHOD AND SYSTEM FOR

MEASURING DIFFERENTIAL SCATTERING OF LIGHT OFF OF :

SAMPLE SURFACES

Commissioner for Patents P.O. Box 1450

Alexandria, VA 22313-1450

SECOND STATUS INQUIRY

Sir:

A Status Inquiry was filed on May 2, 2005, in the above-identified application. To date, Applicant has not received a response from the Patent Office indicating the status of the application. In this regard, more than twenty-four months have elapsed since the filing date and no Office Action has been received by Applicant. Accordingly, Applicant again respectfully requests that the undersigned attorney be informed of the status of the referenced application.

Respectfully submitted,

McDERMOTT WILL & EMERY LLP

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